

Our Reference: H0004521

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Daniel E. Bause et al.  
Serial Number: 10/806,942  
Filing Date: March 23, 2004  
Examiner/Art Group Unit: Unknown/1724  
Title: EVAPORATIVE EMISSIONS FILTER

CERTIFICATE OF MAILING AND TRANSMITTAL LETTER

Commissioner for Patents  
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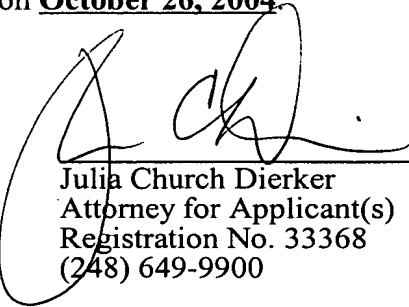
Sir:

Transmitted with this document is two (2) Postcards; Information Disclosure Statement and PTO Form 1449 (5 sheets) including non-U.S. patent cited references in the above-identified application.

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I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on October 26, 2004.

  
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**INFORMATION DISCLOSURE STATEMENT**

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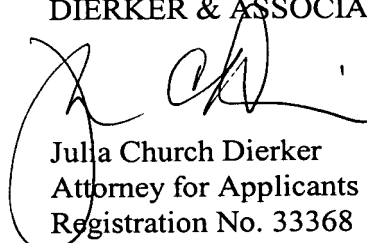
Sir:

Applicants hereby cite the references listed in the attached form PTO-1449 as relating to the subject matter of the invention described and claimed in the above-identified application.

A copy of each non-U.S. patent cited reference is enclosed.

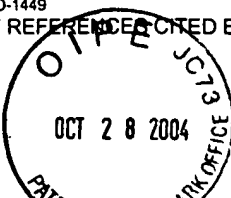
Respectfully submitted,

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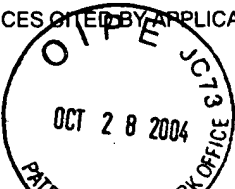
FORM PTO-1449 LIST OF REFERENCES CITED BY APPLICANT 	ATTY DOCKET NO. H0004521	SERIAL NO. 10/806,942
	APPLICANT DANIEL E. BAUSE ET AL.	
	FILING DATE MARCH 23, 2004	GROUP

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EXAMINER	DATE CONSIDERED
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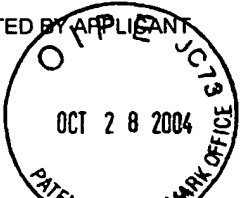
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